Electronic structure of ZrTiO₄, HfTiO₄, FeTiO₃ and MgTiO₃ titanates: Theoretical calculations and x-ray spectroscopy studies

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The modified augmented plane wave (APW) method as incorporated in the WIEN2k code [1] and/or cluster FEFF8 program [2] have been used to calculate total and partial densities of states of the constituent atoms in FeTiO₃, MgTiO₃, ZrTiO₄ and HfTiO₄ titanates, prospective materials for their application in the field of microwave communication and dynamic random access memory (DRAM) devices and they are indispensable components used intensively in wireless-communication systems (e.g. in the mobile phones satellite communications), catalysts in some oxidation reactions, humidity sensors, optical devices, and high-*k* gate insulator.

To verify the theoretical results, in the present work, the X-ray emission Ti $L\alpha$, Fe $L\alpha$, Zr $L\beta_{2,15}$ and O $K\alpha$ bands representing the energy distribution of mainly the Ti 3*d*-, Fe 3d-, Zr 4d- and O 2*p*-like states, respectively, as well as the X-ray photoelectron (XPS) valence-band and core-level spectra have been measured for FeTiO₃, MgTiO₃, ZrTiO₄ and HfTiO₄ oxides.

The theoretical APW/FEFF8 data reveal that the valence band of the above oxides under consideration is dominated by contributions of the O 2p states. These states contribute throughout the whole valence-band region; however their maximum contributions occur in the upper portion of the band. The calculations render that the bottom of the conduction band of FeTiO₃, MgTiO₃, ZrTiO₄ and HfTiO₄ is dominated by contributions of the Ti $3d^*$ states. The experimental data were found to be in good agreement with the theoretical results for all the compounds studied.

Measurements of XPS core-level binding energies for the constituent atoms of the $ZrTiO_4$ to $HfTiO_4$ titanates indicate that Ti and Zr(Hf) atoms are in the formal valence states +4. When going from $ZrTiO_4$ to $HfTiO_4$, the XPS Ti 2p and O 1s core-level binding energies do not alter within the accuracy of the present measurements.

References

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